

# WinhiSemi

**VTGA060N02TA**

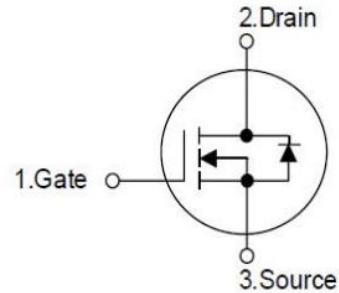
**Datasheet**

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### General Description

VTGA060N02TA N-Channel MOSFET is based on unique device design to achieve low  $R_{DS(ON)}$ , low gate charge, fast switching and excellent avalanche characteristics.

### Symbol

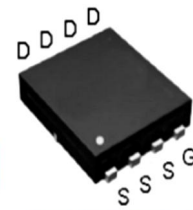


Symbol of VTGA060N02TA

### Features

- Low  $R_{DS(ON)}$  & FOM
- $R_{DS(ON)_{max}} = 14m\Omega @ V_{GS} = 4.5V$
- Extremely low switching loss
- Fast switching and soft recovery

### Package Type



Package Type of VTGA060N02TA

### Application

- Charging Circuit
- Battery Applications
- Synchronous Rectification
- High Frequency Switching

### Ordering Information

Product Name	Package	Marking
VTGA060N02TA	DFN3*3	60N02

## Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	18	V
Gate-Source Voltage	$V_{GS}$	$\pm 8$	V
Continuous Drain Current <sup>Note 1</sup> , $T_C=25^\circ\text{C}$	$I_D$	22	A
Pulsed Drain Current <sup>Note 2</sup>	$I_{DM}$	66	A
Max Power Dissipation <sup>Note 3</sup> , $T_C=25^\circ\text{C}$	$P_D$	19.4	W
Avalanche Current, Single Pulse <sup>Note 5</sup>	$I_{AS}$	28.49	A
Avalanche Energy, Single Pulse <sup>Note 5</sup>	$E_{AS}$	121.7	mJ
Operation Junction temperature	$T_J$	-55 to 150	$^\circ\text{C}$

## Thermal Resistance

Parameter	Symbol	Min	Typ	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$		6.45		$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-Ambient <sup>Note 4</sup>	$R_{\theta JA}$		62		

Notes:

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3)  $P_D$  is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_a=25^\circ\text{C}$ .
- 5)  $V_{DS}=15\text{V}$ ,  $V_{GS}=4.5\text{V}$ ,  $L=0.3\text{mH}$ ,  $R_g=25\Omega$ , starting  $T_J=25^\circ\text{C}$ .

**Electrical Characteristics** ( $T_J=25\text{ }^\circ\text{C}$ , unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>Statistic Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	18			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=18V, V_{GS}=0V$			1	$\mu A$
Gate-Body Leakage Current	$I_{GSS}$	$V_{GS}=\pm 8V, V_{DS}=0V$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.35	0.55	0.85	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=4.5V, I_D=5A$		10.8	14	$m\Omega$
		$V_{GS}=4.5V, I_D=15A$		11.4	14	$m\Omega$
Gate Resistance	$R_G$	$f=1MHz, \text{open drain}$		0.79		$\Omega$
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{GS}=0V$		1207		pF
Output Capacitance	$C_{oss}$	$V_{DS}=10V$		855.5		pF
Reverse Transfer Capacitance	$C_{rss}$	$f=1MHz$		90		pF
Turn-on Delay Time	$t_{d(on)}$	$V_{DS}=15V$		10		ns
Rise Time	$t_r$	$V_{GS}=4.5V$		3.2		
Turn-off Delay Time	$t_{d(off)}$	$I_D=6A$		35.8		
Fall Time	$t_f$	$R_G=3\Omega$		11		
<b>Switching Characteristics</b>						
Total Gate Charge (@ $V_{GS}=8V$ )	$Q_g$	$V_{GS}=0 \text{ to } 8V$ $V_{DS}=10V$ $I_D=15A$		27.7		nC
Total Gate Charge (@ $V_{GS}=4.5V$ )	$Q_g$		16.1			
Gate to Source Charge	$Q_{gs}$		2.44			
Gate to Drain Charge	$Q_{gd}$		4.35			
<b>Reverse Diode Characteristics</b>						
Drain-Source Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_{SD}=12A$		0.82	1.2	V
Reverse Recovery Time	$t_{rr}$	$V_{DS}=10V$		34.02		ns
Reverse Recovery Charge	$Q_{rr}$	$I_F=12A$		16.26		nC
Peak Reverse Recovery Current	$I_{rrm}$	$di/dt=100A/\mu s$		0.7		A

Typical Performance Characteristics

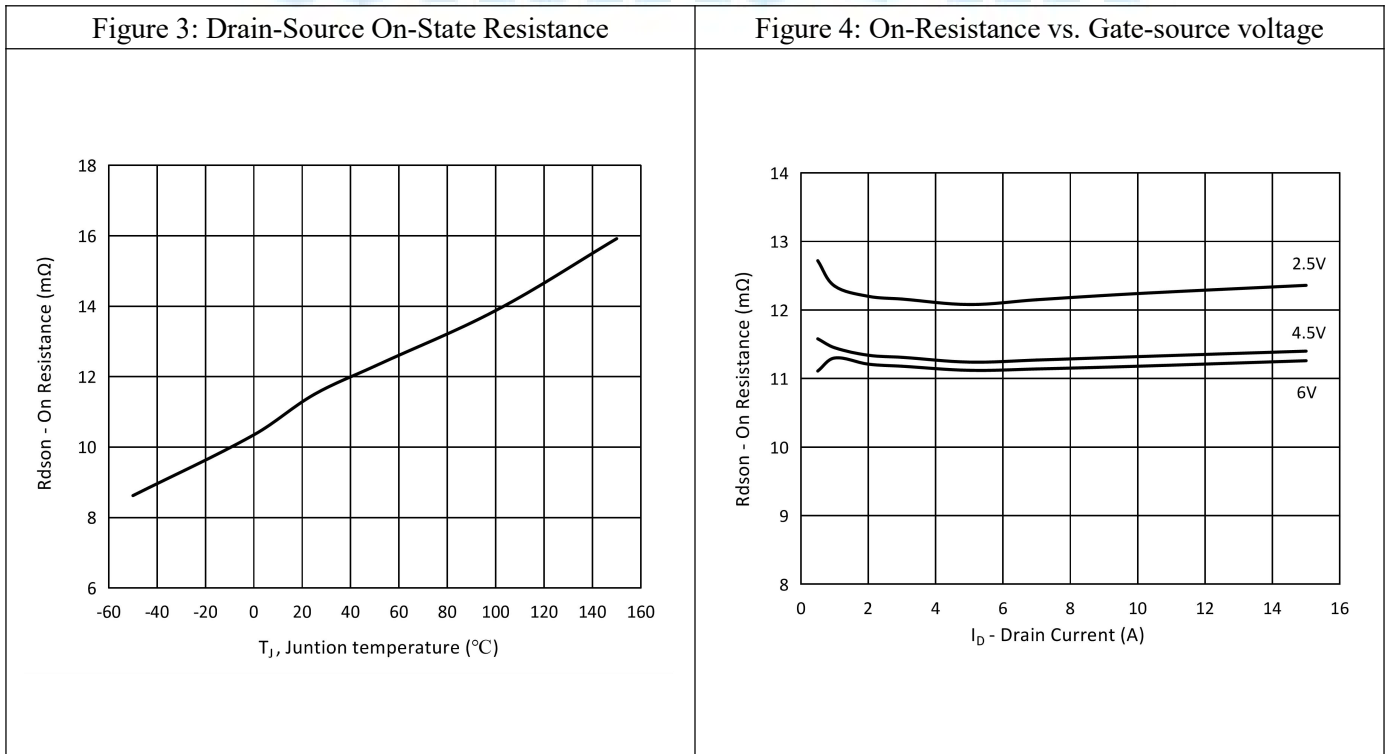
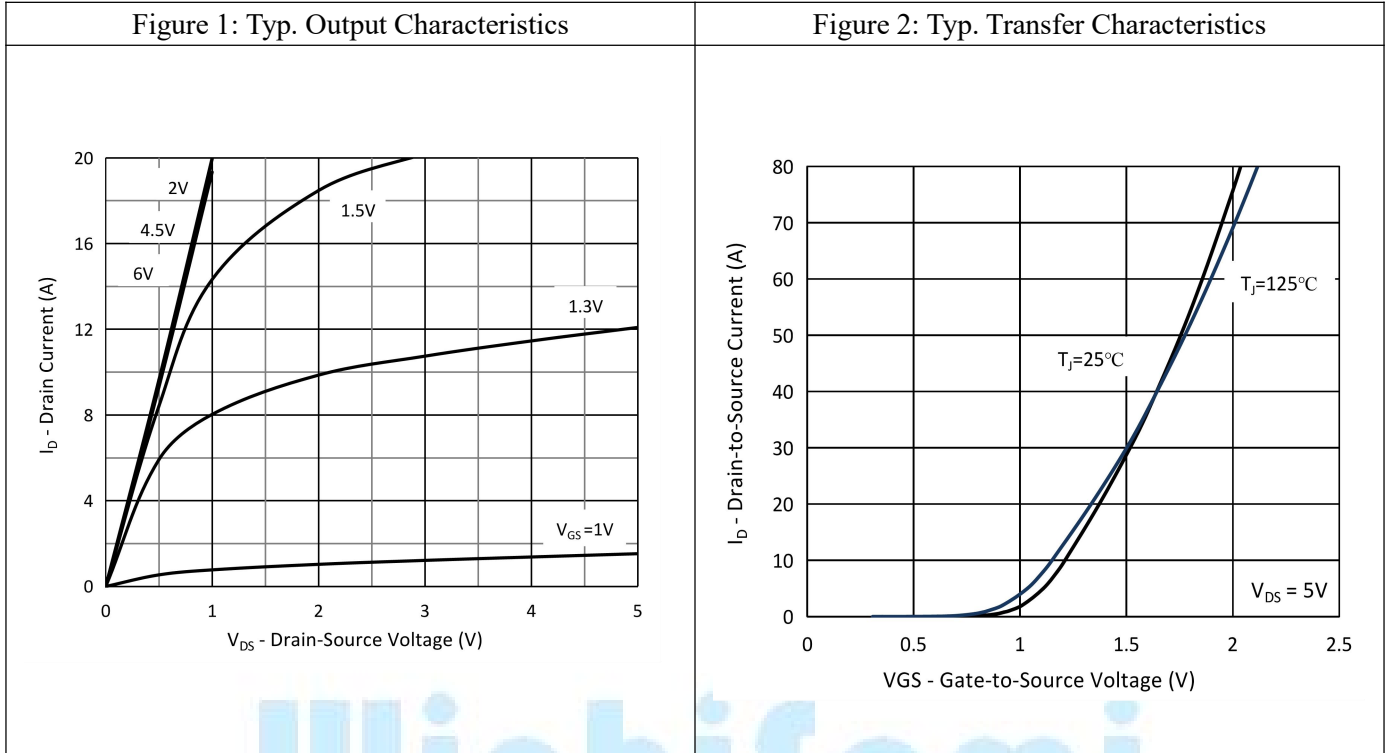


Figure 5: Typ. Capacitances

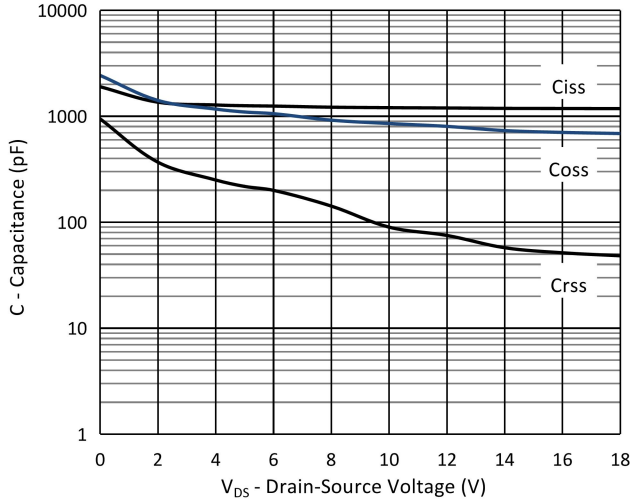


Figure 6: Gate Charge Characteristics

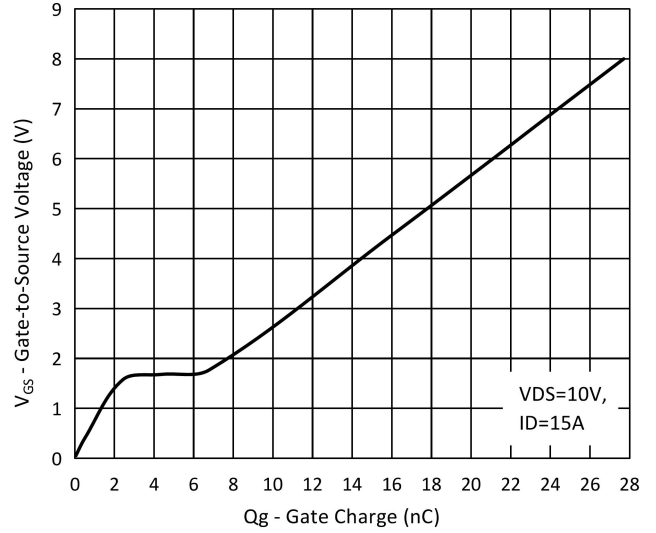


Figure 7: Forward Characteristics of Body Diode

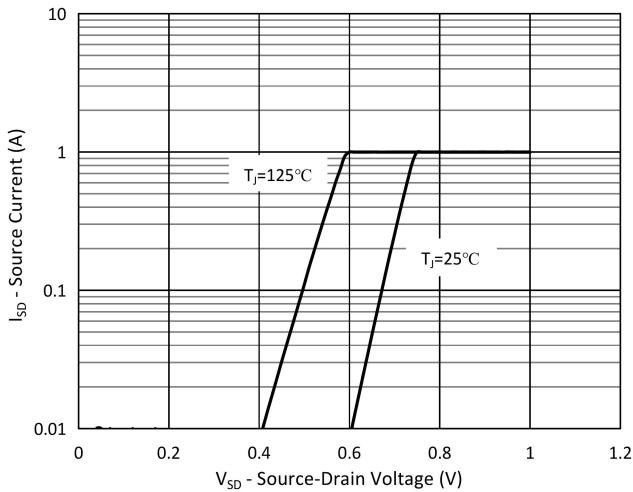


Figure 8: Safe Operating Area T<sub>C</sub>=25°C

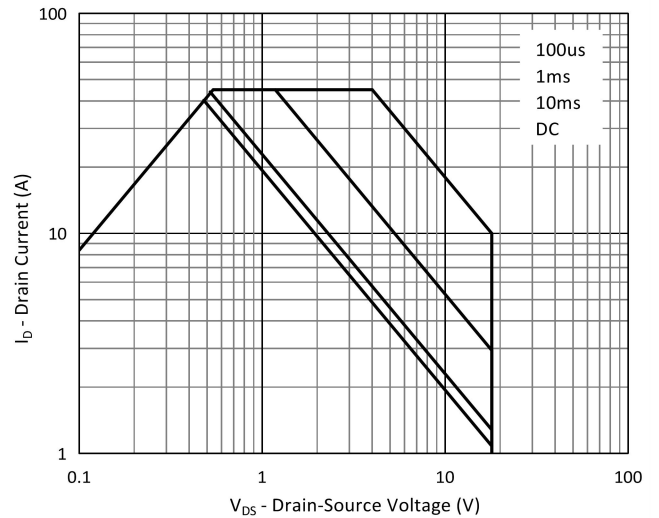


Figure 9: Power De-rating

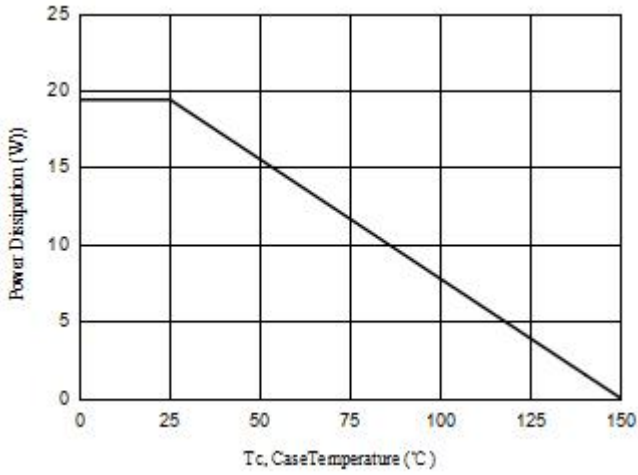


Figure 10: Current De-rating

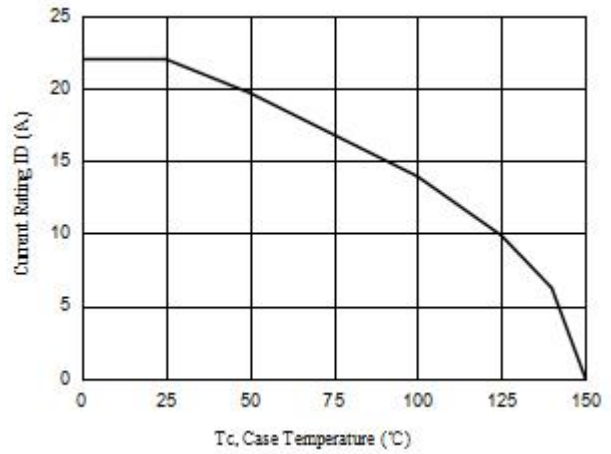


Figure 11: Single pulse power rating, Junction to case

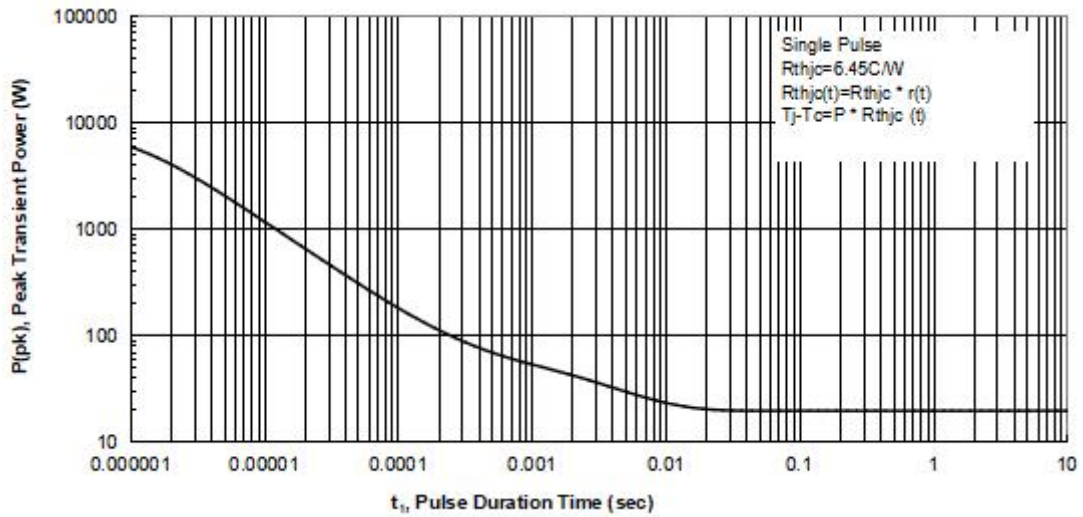
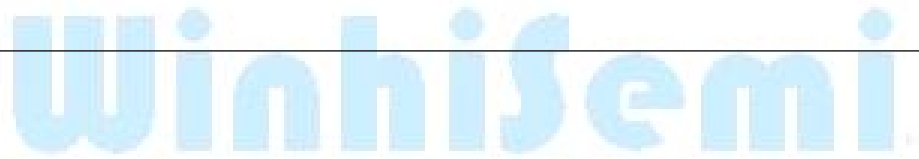
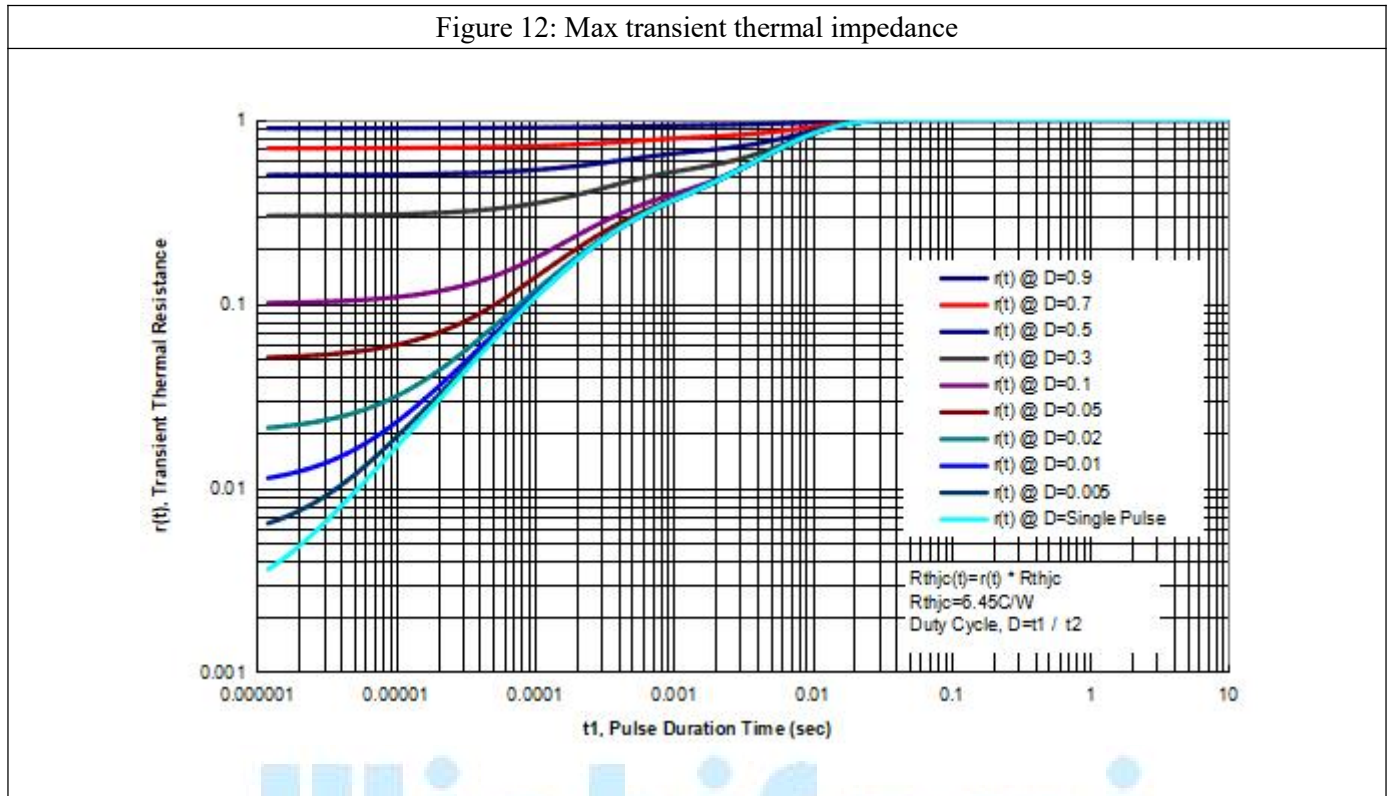
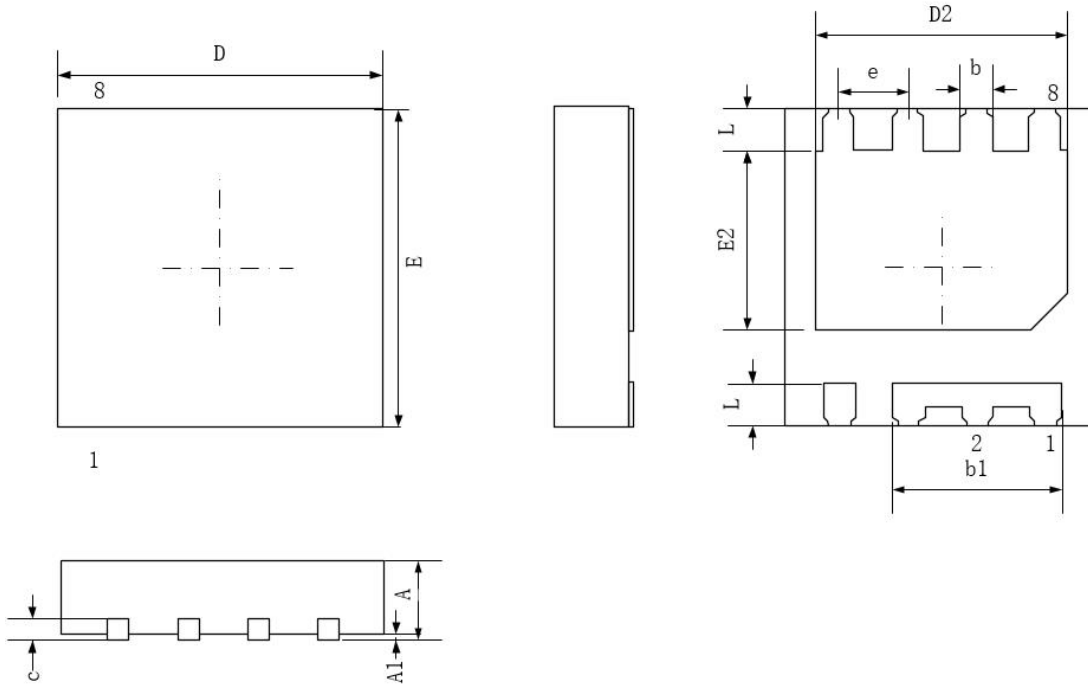


Figure 12: Max transient thermal impedance





### Mechanical Dimensions (DFN3\*3 Unit:mm)



SYMBOL	MILLMETER		
	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
b	0.25	0.30	0.35
b1	1.55	1.60	1.65
c	0.19	0.20	0.21
D	2.90	3.00	3.10
D2	2.30	2.40	2.50
E	2.90	3.00	3.10
E2	1.60	1.70	1.80
e	0.65BSC		
L	0.35	0.40	0.45

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